

Secondary Ion Mass Spectrometry (SIMS)	Canadian \$
Cameca IMS-3f with oxygen or caesium source	\$200.00/hou
• ION-TOFTOF-SIMSIV with Ga+, Cs+, SF5+, Ar+, O+, and C60+ beams, 8" sample stage	\$200.00/hou
X-ray Photoelectron Spectroscopy (XPS)	ф200 00 /l
 Kratos AXIS Supra Kratos AXIS Nova 	\$200.00/hou \$200.00/hou
	Ψ200.00/110α
Auger Electron Spectroscopy (AES) PHI 710 Field Emission Scanning Auger Nanoprobe	\$200.00/hou
Scanning Electron Microscopy (SEM) with Energy Dispersive X-ray (EDX) Spectroscopy	·
Hitachi SU8230 Regulus Ultra High-Resolution Field Emission SEM	\$180.00/hou
Bruker X-Flash FQ5060 Annular Quad X-ray Analyzer	
Bruker X-Flash 6160 X-ray Analyzer	
Hitachi SU3900 Variable Pressure Large Chamber SEM with an Oxford ULTIMAX 65 SDD X-ray Analyzer Hitachi SU3500 Variable Pressure SEM with an Oxford Artes X May 50 SDD X-ray Analyzer	\$180.00/hou
Hitachi SU3500 Variable Pressure SEM with an Oxford Aztec X-Max50 SDD X-ray Analyzer	\$180.00/hou
Atomic Force Microscopy (AFM) Park Systems XE-100	\$180.00/hou
Surface Profilometry	+ 10010071100
KLA-Tencor-17	\$180.00/hou
Zeiss LSM800 Confocal Laser Scanning Microscope	\$180.00/hou
Laser Raman Spectroscopy	
Renishaw InVia Reflex Raman Spectrometer	\$200.00/hou
Fourier Transform Infrared (FTIR) Spectroscopy	
Bruker Tensor II System with Hyperion 2000 Microscope	\$200.00/hou
Optical Microscopy	
 Zeiss Axioplan, Zeiss SteREO Discovery. V8, and Wild M3Z 	\$130.00/hou
Keyence VHX-6000	\$130.00/hou
Contact Angle Goniometry KRÜSS Drop Shape Analyzer DSA30E	\$200.00/hou
Microindentation Hardness Testing Leco LM100	\$110.00/sample
Metallographic Preparation	
• Per sample	\$110.00/sample
Etching	
Standard	\$110.00/sample
Differential Scanning Calorimetry (DSC)	
Mettler Toledo DSC 3	\$130.00/sample
Thermogravimetric Analysis (TGA)	
• Mettler Toledo TGA 2	\$130.00/sample
X-ray Diffraction (XRD)	
Rigaku SmartLab with a 2D Hypix-3000 detector	\$180.00/hou
Micro Computed Tomography (Micro-CT)	
Zeiss Xradia 410 Versa Micro-CT	\$810/per overnight rui
Zeiss Xradia 410 Versa Micro-CT	\$130/per daytime hou
Weathering Chambers O-FOG / Q-SUN / QUV Weathering Chamber	Please call for a quote
Priority Service (based on Monday - Friday business hours, excluding weekends and holidays)	
• Five business days	25% surcharge
• Three business days	50% surcharge
One business day	100% surcharge
Advanced Reporting, Consulting, Data Interpretation, Post-analytical Data Processing, Sample Preparation Hourly basis	\$180.00/hou
Project Administration Fee	

Project Administration Fee

• 10% of total job